

SEMITRANS[®] 3

SiC MOSFET Module

SKM350MB120SCH15

Features*

- Full Silicon Carbide (SiC) power module
- High reliability 2nd Generation SiC MOSFETs
- Optimized for fast switching and lowest power losses
- High humidity robustness (HV-H3TRB proof)
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Improved thermal performances with Aluminium Nitride (AIN) substrate
- UL recognized, file no. E63532

Typical Applications

- High frequency power supplies
- AC inverters
- Traction APU
- EV Chargers
- Industrial Test Systems

Remarks

- Case temperature limited to T_C = 125°C max.
- Recommended T_{jop} = -40 ... +150°C
- Gate-Source SURGE VOLTAGE (t_{surge}<300ns), V_{GS_surge} = -10V ... +26V



Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
Module			
I _{t(RMS)}		500	А
T _{stg}	module without TIM	-40 125	°C
V _{isol}	AC sinus 50 Hz, t = 1 min	4000	V





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Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
MOSFET						
V _{(BR)DSS}	$V_{GS} = 0 V, I_D = 1 m/$	A, T _j = 25 °C	1200			V
V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 71.2 \text{ mA}$		1.6		4	V
I _{DSS}	$V_{GS} = 0 V, V_{DS} = 1200 V, T_j = 25 °C$				1	mA
I _{GSS}	V _{GS} = 22 V, V _{DS} = 0 V				800	nA
R _{DS(on)}	V _{GS} = 18 V	T _j = 25 °C		5.6	7.0	mΩ
	I _D = 176 A chiplevel	T _j = 150 °C		9.5		mΩ
C _{iss}	$V_{GS} = 0 V$	T _j = 25 °C		34.5		nF
Coss	V _{DS} = 800 V	T _j = 25 °C		1.10		nF
C _{rss}	f = 1 MHz	T _j = 25 °C		0.15		nF
Q_{G}	V _{DD} =600V, V _{GS} =-5	20V, I _D = 350 A		1850		nC
R _{Gint}	T _j = 25 °C			0.6		Ω
t _{d(on)}	$V_{DD} = 600 V$	T _j = 150 °C		86		ns
t _r	$I_{\rm D} = 175 {\rm A}$	T _j = 150 °C		11		ns
t _{d(off)}	$V_{GS} = -5 \dots 20 V$ $R_{Con} = 0.5 \Omega$	T _j = 150 °C		226		ns
t _f	$R_{Goff} = 0.5 \Omega$	T _j = 150 °C		34		ns
Eon	di/dt _{on} = 10.1 kA/	T _j = 150 °C		2.31		mJ
E _{off}	$\label{eq:linear} \begin{array}{l} \mu s \\ di/dt_{off} = 2.8 \ \text{kA}/\mu s \\ dv/dt_{off} = 20.1 \ \text{kV}/ \\ \mu s \end{array}$	T _j = 150 °C		2.07		mJ
R _{th(j-c)}	per MOSFET				0.055	K/W
R _{th(c-s)}	per MOSFET (λ_{grea}	_{se} =0.81 W/(m*K))		0.03		K/W
Integrated	d body diode					-
$V_{\rm F} = V_{\rm SD}$	$-I_{\rm D} = 176 {\rm A}$	T _j = 25 °C		4.10		V
	v _{GS} = 0 v chiplevel	T _j = 150 °C		3.90		V
V _{F0}	chiplevel	T _j = 25 °C		2.6		V
	chipievei	T _j = 150 °C		2.1		V
r _F	chiplevel	T _j = 25 °C		8.5		mΩ
	emplevel	T _j = 150 °C		10		mΩ
t _{rr}	$V_{DD} = 600 V$	T _j = 150 °C		62		ns
Q _{rr}	-I _D = 175 A di/dt _{off} = 7.5 kA/μs V _{GS} = -5 V	T _j = 150 °C		7.2		μC
l _{rr}		T _j = 150 °C		232		Α
Err	$R_{Gon} = 0.5 \Omega$	T _j = 150 °C		3.3		mJ

Characteristics								
Symbol	Conditions	min.	typ.	max.	Unit			
Module			•					
L _{CE}				15		nH		
R _{CC'+EE'}	measured per switch	T _C = 25 °C		0.55		mΩ		
		T _C = 125 °C		0.85		mΩ		
R _{th(c-s)1}	calculated without thermal coupling $(\lambda_{grease}=0.81 \text{ W}/(\text{m}^{*}\text{K}))$			0.015		K/W		
R _{th(c-s)2}	including thermal coupling, T _s underneath module $(\lambda_{grease}=0.81 \text{ W/(m*K)})$			0.016		K/W		
Ms	to heat sink M6		3		5	Nm		
Mt		to terminals M6	2.5		5	Nm		
	1					Nm		
w					325	g		













Fig. 4: Typ. switching energy $E = f(I_D)$ at R_{G1}





























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This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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